

<b>Notice of References Cited</b>	Application/Control No. 10/714,918	Applicant(s)/Patent Under Reexamination HONKURA ET AL.	
	Examiner John P. Sheehan	Art Unit 1742	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,814,776 B2	11-2004	Kanekiyo et al.	75/244
*	B	US-2003/0019546 A1	01-2003	Kanekiyo et al.	148/105
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2000-003809	01-2000	Japan	Kaneko et al.	-----
	O	05-055020	03-1993	Japan	Takei et al.	-----
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Machine Translation of Japanese Patent Document No. 2000-003809.
	V	Machine Translation of Japanese Patent Document No. 06-132107.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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